

V_{DSS}	30V
$R_{DS(on)(Max.)}$	21.4m Ω
I_D	$\pm 9.0A$
P_D	3.0W

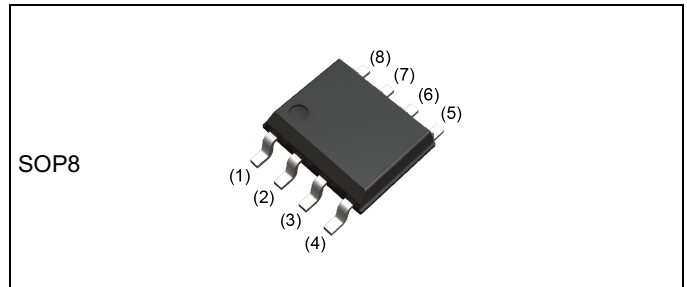
●Features

- 1) Low on - resistance.
- 2) Small Surface Mount Package (SOP8).
- 3) Pb-free lead plating ; RoHS compliant.
- 4) Halogen Free.

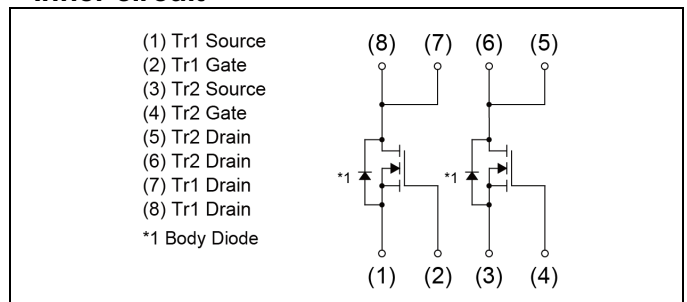
●Application

Switching
Motor Drive

●Outline



●Inner circuit



●Packaging specifications

Type	Packing	Embossed Tape
	Reel size (mm)	330
	Tape width (mm)	12
	Basic ordering unit (pcs)	2500
	Taping code	TB
	Marking	SH8KA4

●Absolute maximum ratings ($T_a = 25^\circ C$,unless otherwise specified) <Tr1 and Tr2>

Parameter	Symbol	Value	Unit
Drain - Source voltage	V_{DSS}	30	V
Continuous drain current	I_D^{*1}	± 9.0	A
Pulsed drain current	I_{DP}^{*2}	± 18	A
Gate - Source voltage	V_{GSS}	± 20	V
Avalanche current, single pulse	I_{AS}^{*3}	8.0	A
Avalanche energy, single pulse	E_{AS}^{*3}	4.6	mJ
Power dissipation	total	P_D^{*1}	3.0
		P_D^{*4}	2.0
		P_D^{*5}	1.4
	element	P_D^{*4}	1.4
Junction temperature	T_j	150	$^\circ C$
Operating junction and storage temperature range	T_{stg}	-55 to +150	$^\circ C$

● Thermal resistance

Parameter	Symbol	Values			Unit	
		Min.	Typ.	Max.		
Thermal resistance, junction - ambient	total	R_{thJA}^{*4}	-	-	62.5	°C/W
	element		-	-	89.2	
	total	R_{thJA}^{*5}	-	-	89.2	

● Electrical characteristics ($T_a = 25^\circ\text{C}$) <Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Drain - Source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 1mA$	30	-	-	V
Breakdown voltage temperature coefficient	$\frac{\Delta V_{(BR)DSS}}{\Delta T_j}$	$I_D = 1mA$ referenced to 25°C	-	21	-	mV/°C
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1	μA
Gate - Source leakage current	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 1mA$	1.0	-	2.5	V
Gate threshold voltage temperature coefficient	$\frac{\Delta V_{GS(th)}}{\Delta T_j}$	$I_D = 1mA$ referenced to 25°C	-	-3	-	mV/°C
Static drain - source on - state resistance	$R_{DS(on)}^{*6}$	$V_{GS} = 10V, I_D = 9.0A$	-	16.5	21.4	mΩ
		$V_{GS} = 4.5V, I_D = 8.0A$	-	22.2	28.9	
Gate resistance	R_G	$f = 1MHz, \text{open drain}$	-	3.4	-	Ω
Forward Transfer Admittance	$ Y_{fs} ^{*6}$	$V_{DS} = 5V, I_D = 8.0A$	4.6	-	-	S

*1 $P_w \leq 1s$, Mounted on a ceramic board (30×30×0.8mm), Limited only by maximum temperature allowed.

*2 $P_w \leq 10\mu s$, Duty cycle $\leq 1\%$

*3 $L \approx 0.1mH$, $V_{DD} = 15V$, $R_G = 25\Omega$, STARTING $T_j = 25^\circ\text{C}$ Fig.3-1,3-2

*4 Mounted on a ceramic board (30×30×0.8mm)

*5 Mounted on a FR4 (25×25×0.8mm)

*6 Pulsed

●Electrical characteristics ($T_a = 25^\circ\text{C}$) <Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Input capacitance	C_{iss}	$V_{GS} = 0V$	-	640	-	pF
Output capacitance	C_{oss}	$V_{DS} = 15V$	-	110	-	
Reverse transfer capacitance	C_{rss}	$f = 1\text{MHz}$	-	90	-	
Turn - on delay time	$t_{d(on)}^{*6}$	$V_{DD} \approx 15V, V_{GS} = 10V$	-	8	-	ns
Rise time	t_r^{*6}	$I_D = 4.5A$	-	19	-	
Turn - off delay time	$t_{d(off)}^{*6}$	$R_L = 3.3\Omega$	-	33	-	
Fall time	t_f^{*6}	$R_G = 10\Omega$	-	7	-	

●Gate charge characteristics ($T_a = 25^\circ\text{C}$) <Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit	
			Min.	Typ.	Max.		
Total gate charge	Q_g^{*6}	$V_{DD} \approx 15V$ $I_D = 9.0A$	$V_{GS} = 10V$	-	15.5	-	nC
Gate - Source charge	Q_{gs}^{*6}		$V_{GS} = 4.5V$	-	7.9	-	
Gate - Drain charge	Q_{gd}^{*6}			-	3.1	-	
				-	2.8	-	

●Body diode electrical characteristics (Source-Drain) ($T_a = 25^\circ\text{C}$)

<Tr1 and Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Continuous forward current	I_S	$T_a = 25^\circ\text{C}$	-	-	1.67	A
Pulse forward current	I_{SP}^{*2}		-	-	18	
Forward voltage	V_{SD}^{*6}	$V_{GS} = 0V, I_S = 1.67A$	-	-	1.2	V

● Electrical characteristic curves

Fig.1 Power Dissipation Derating Curve



Fig.2 Maximum Safe Operating Area

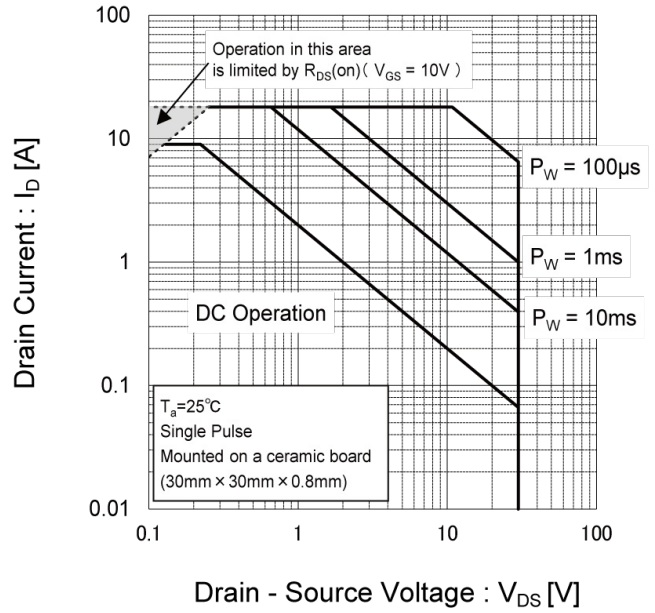


Fig.3 Normalized Transient Thermal Resistance vs. Pulse Width

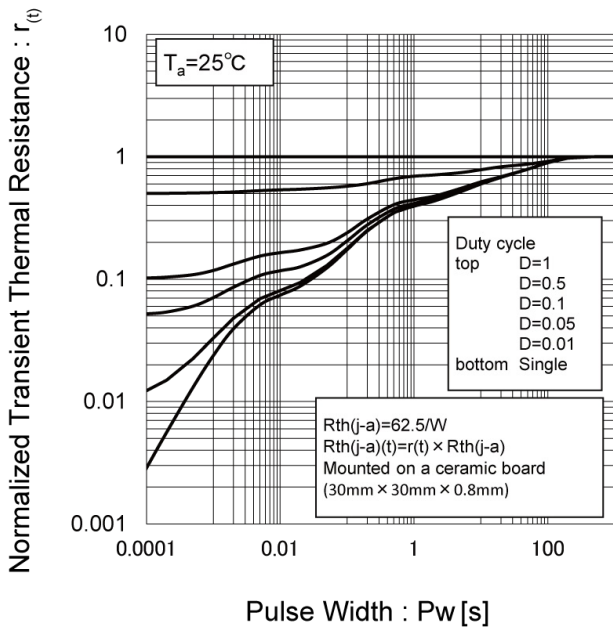
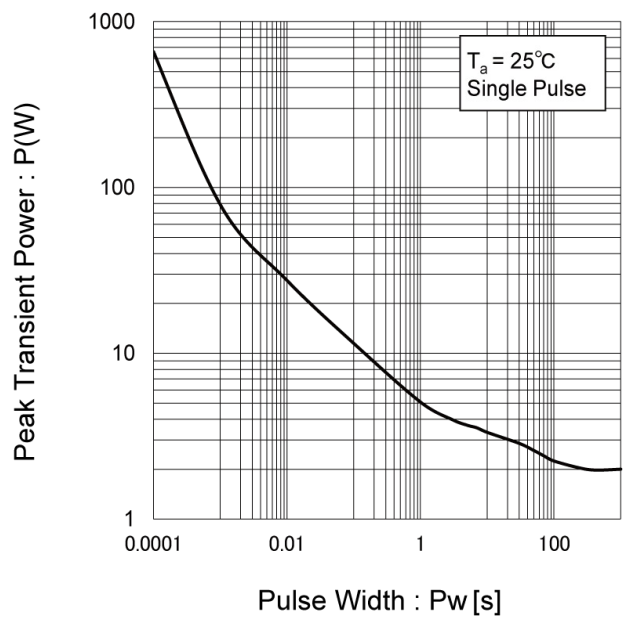


Fig.4 Single Pulse Maximum Power dissipation



● Electrical characteristic curves

Fig.5 Typical Output Characteristics(I)

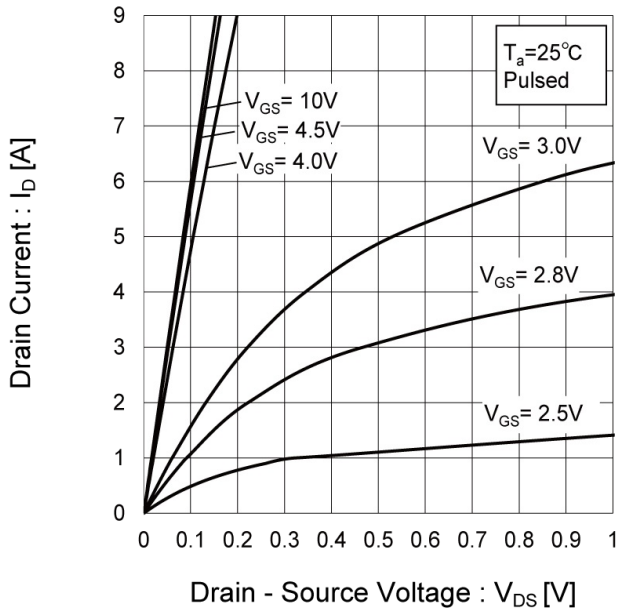


Fig.6 Typical Output Characteristics(II)

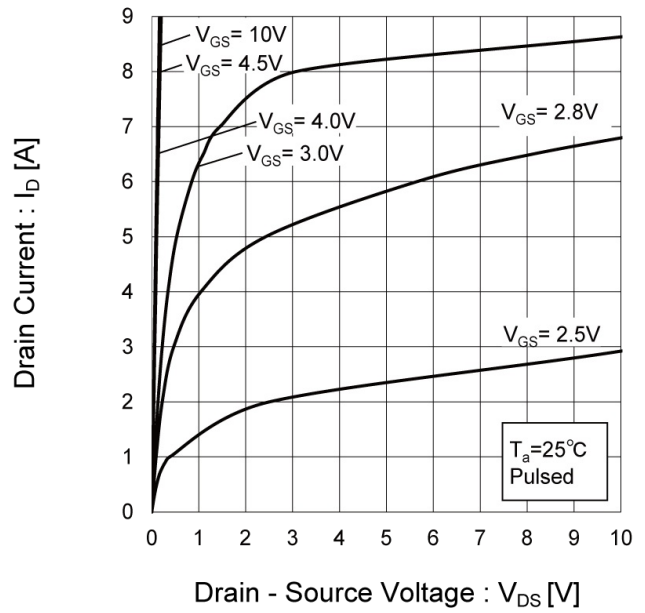
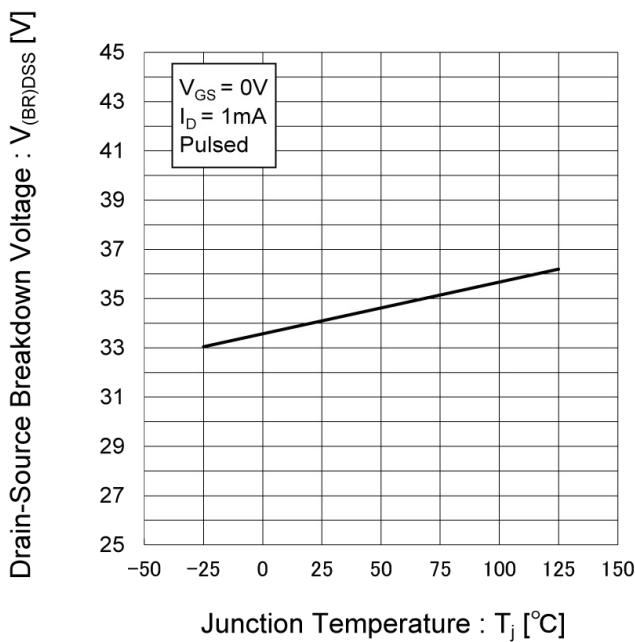


Fig.7 Breakdown Voltage vs. Junction Temperature



● Electrical characteristic curves

Fig.8 Typical Transfer Characteristics

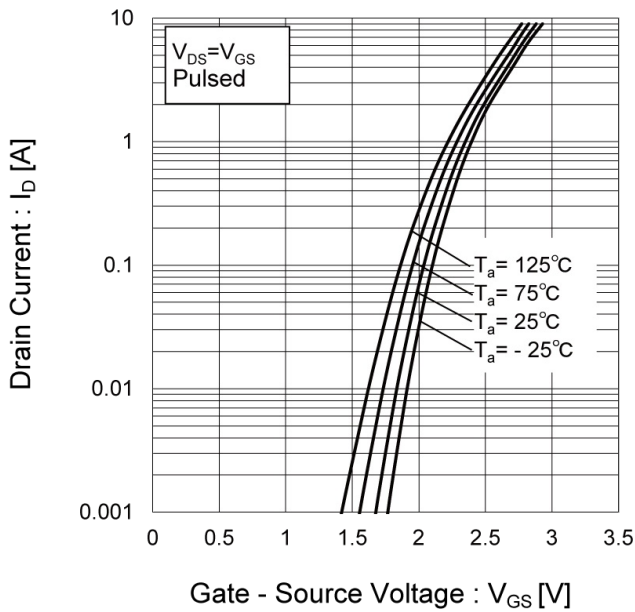


Fig.9 Gate Threshold Voltage vs. Junction Temperature

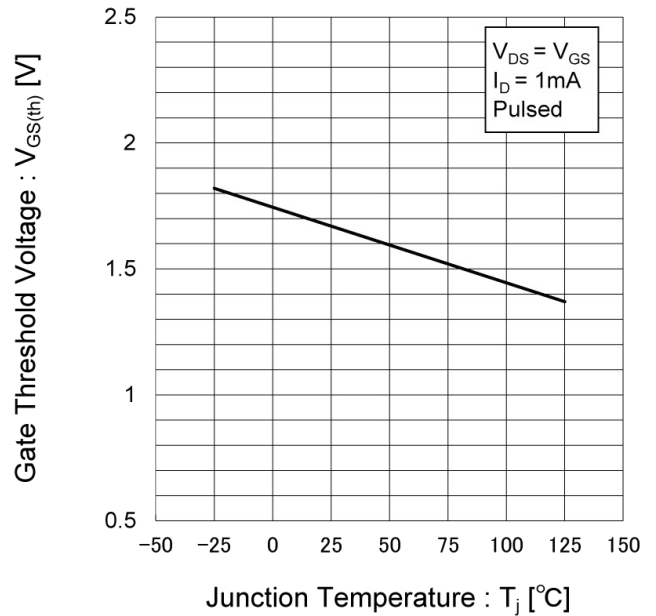
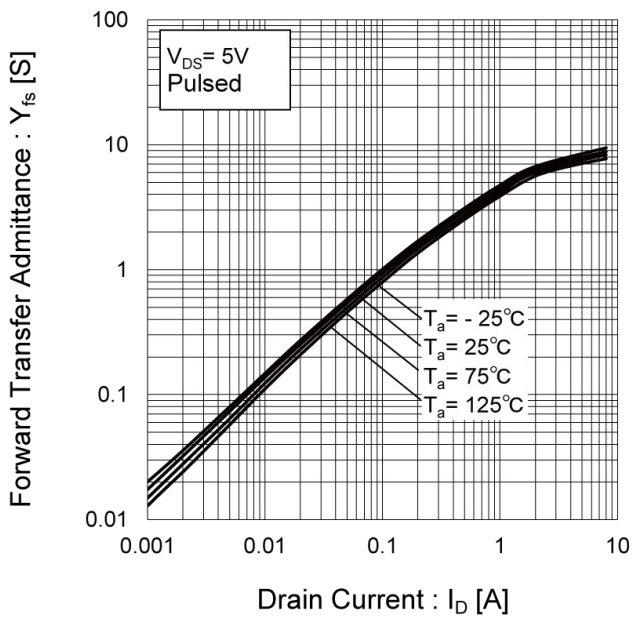


Fig.10 Forward Transfer Admittance vs. Drain Current



● Electrical characteristic curves

Fig.11 Drain Current Derating Curve



Fig.12 Static Drain - Source On - State Resistance vs. Gate Source Voltage

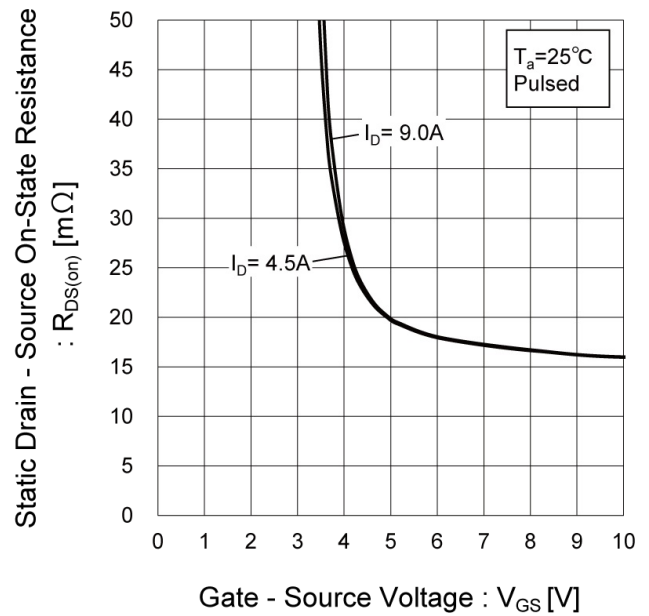
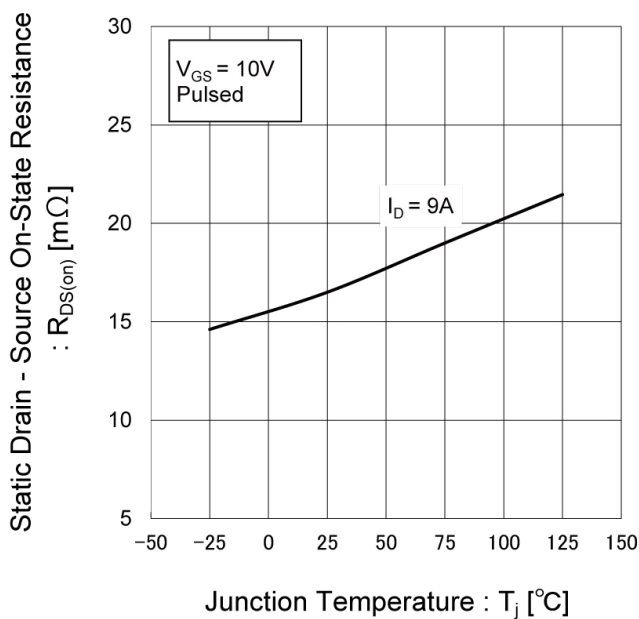


Fig.13 Static Drain - Source On - State Resistance vs. Junction Temperature



● Electrical characteristic curves

Fig.14 Static Drain - Source On - State Resistance vs. Drain Current(I)

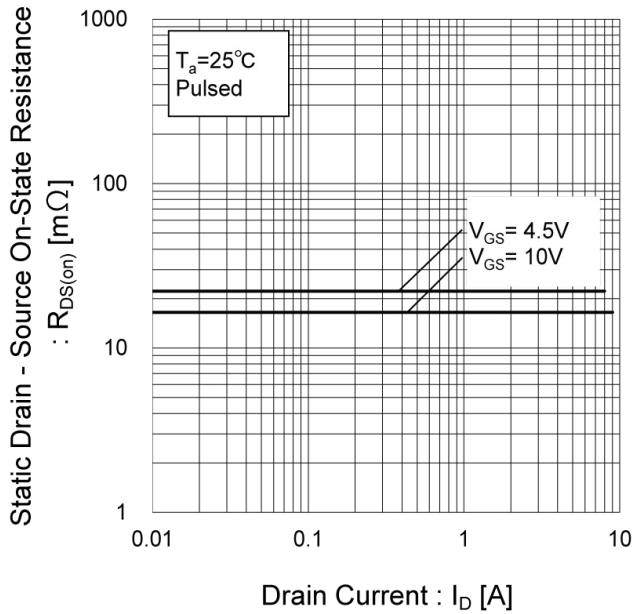


Fig.15 Static Drain - Source On - State Resistance vs. Drain Current(II)

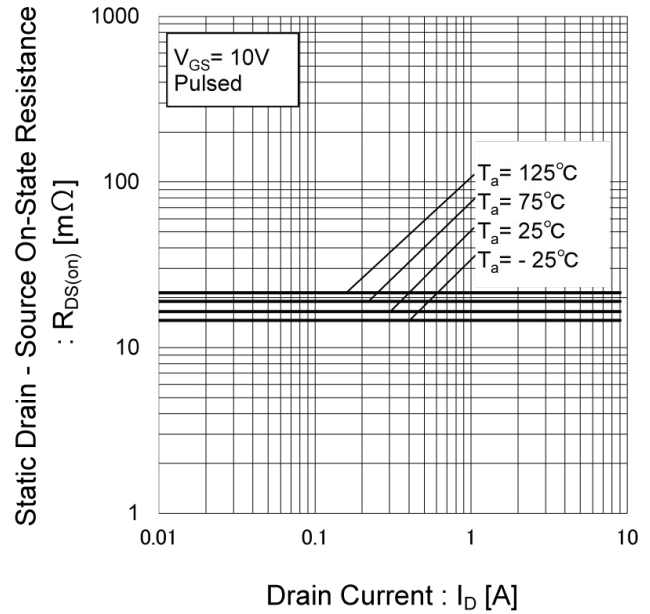
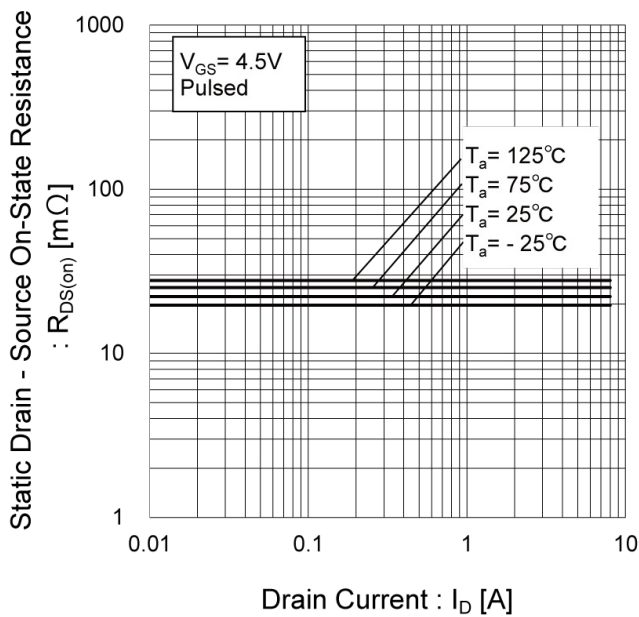


Fig.16 Static Drain - Source On - State Resistance vs. Drain Current(III)



●Electrical characteristic curves

Fig.17 Typical Capacitance vs. Drain - Source Voltage

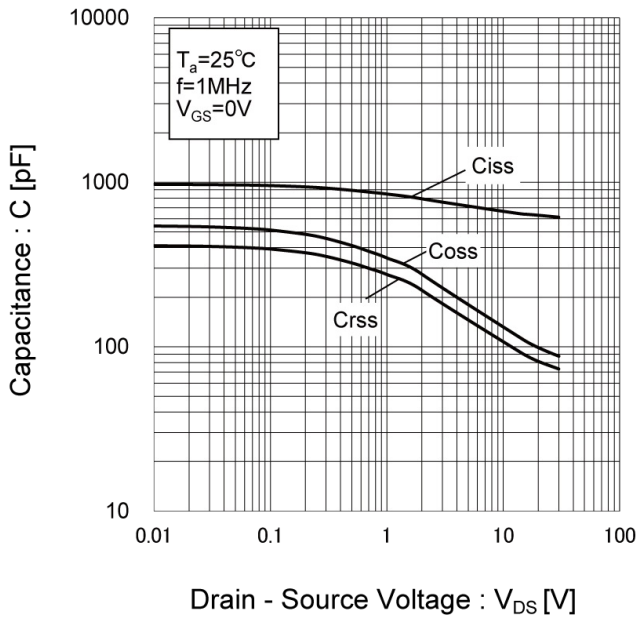


Fig.18 Switching Characteristics

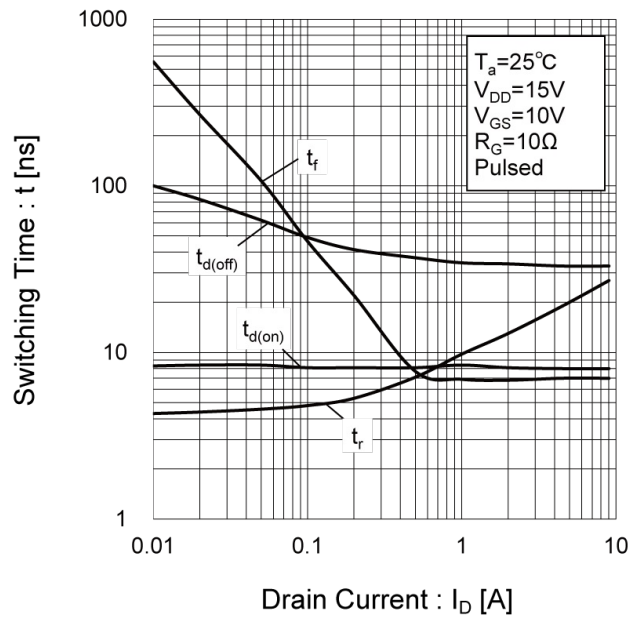


Fig.19 Dynamic Input Characteristics

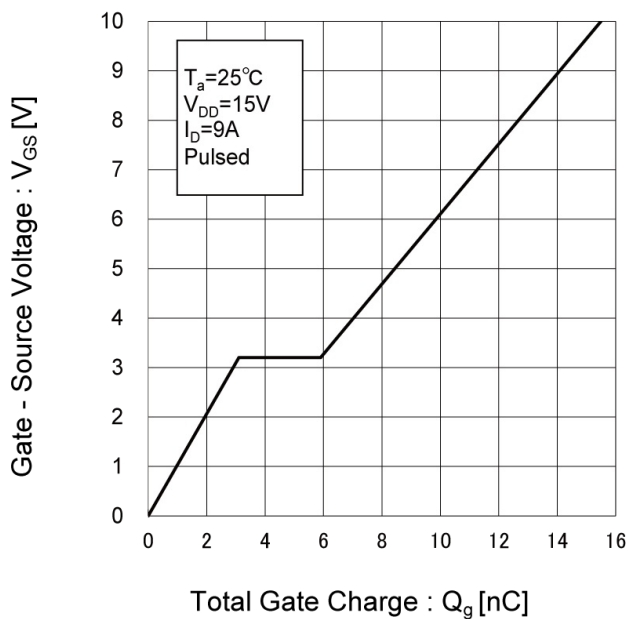
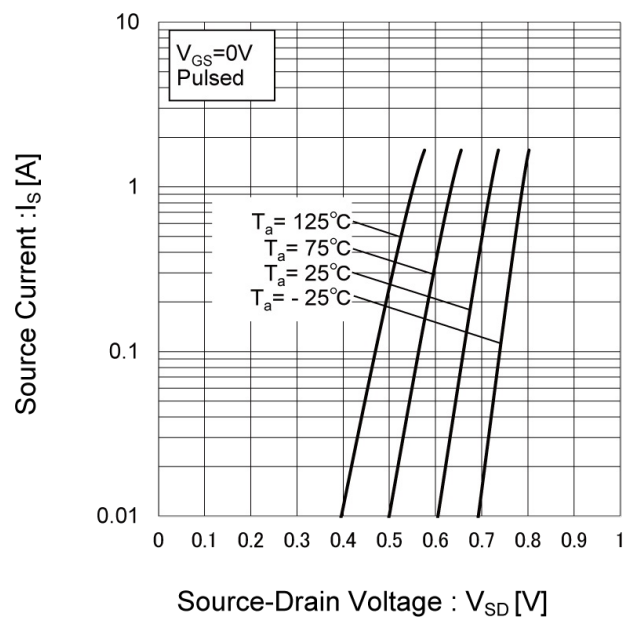


Fig.20 Source Current vs. Source Drain Voltage



● Measurement circuits <It is the same for the Tr1 and Tr2>

Fig.1-1 Switching Time Measurement Circuit

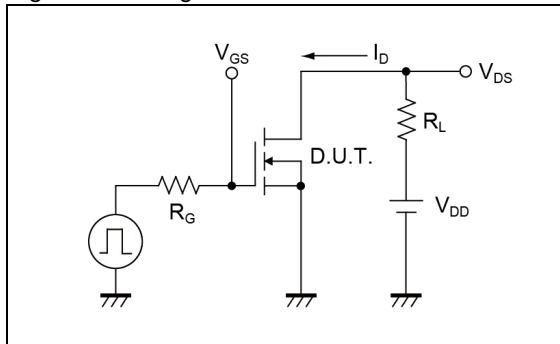


Fig.1-2 Switching Waveforms

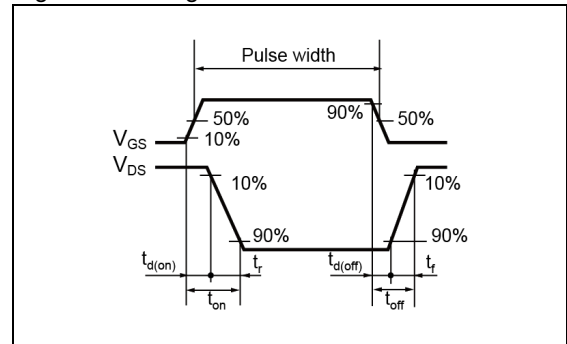


Fig.2-1 Gate Charge Measurement Circuit

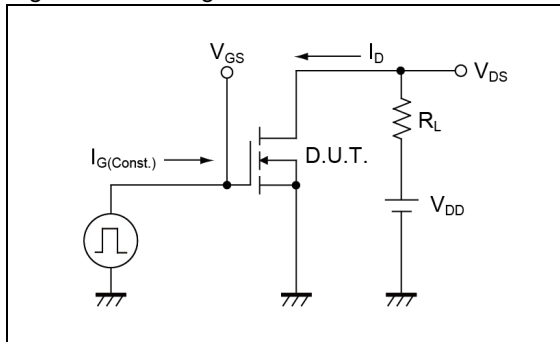


Fig.2-2 Gate Charge Waveform

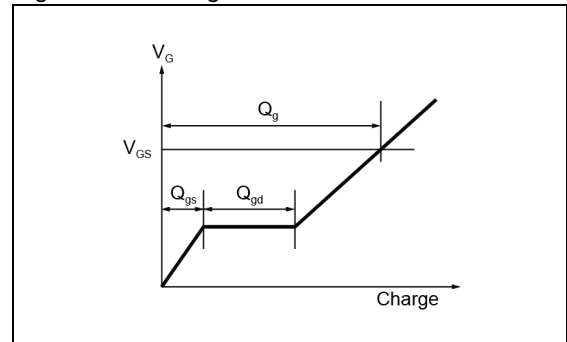


Fig.3-1 Avalanche Measurement Circuit

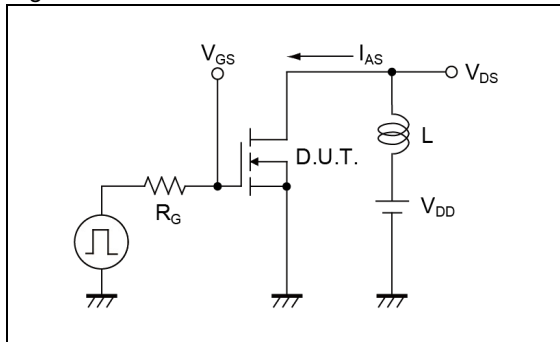
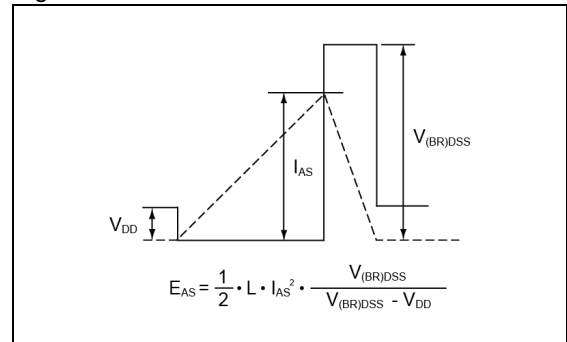


Fig.3-2 Avalanche Waveform

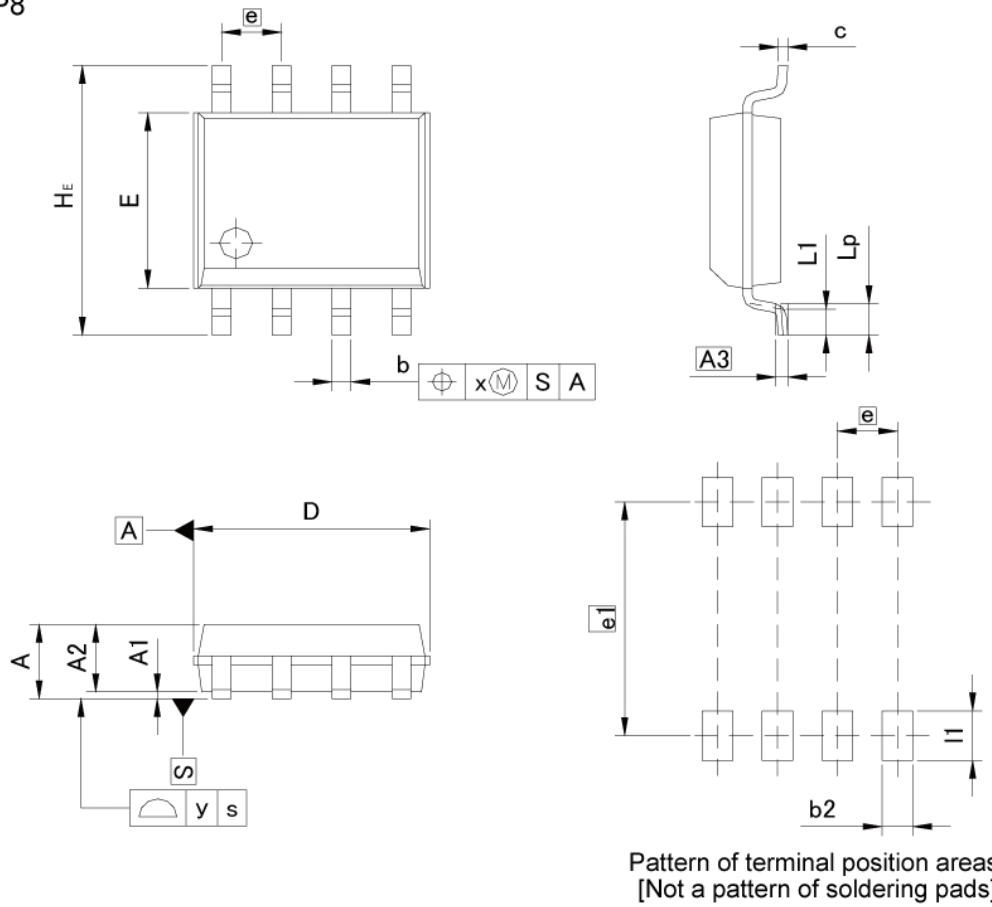


● Notice

This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

●Dimensions

SOP8



DIM	MILIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	-	1.75	-	0.069
A1	0.15		0.006	
A2	1.40	1.60	0.055	0.063
A3	0.25		0.010	
b	0.30	0.50	0.012	0.020
c	0.10	0.30	0.004	0.012
D	4.80	5.20	0.189	0.205
E	3.75	4.05	0.148	0.159
e	1.27		0.050	
HE	5.70	6.30	0.224	0.248
L1	0.40	0.60	0.016	0.024
Lp	0.65	0.85	0.026	0.033
x	0.15		0.006	
y	0.10		0.004	

DIM	MILIMETERS		INCHES	
	MIN	MAX	MIN	MAX
b2	-	0.65	-	0.026
e1	5.15		0.203	
l1	-	1.15	-	0.045

Dimension in mm/inches

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